

<b>FORM PTO-1449</b>	Atty. Docket No.: E252.12-0006	Application No.:
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor: Brian A. Franchuk	
	Filing Date: Herewith	Group Art: 2666

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Examiner Initials	Document No.	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Documents
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AN				

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AO	
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FORM PTO-1449	Atty. Docket No.: E252.12-0006	Application No.: 10/781,374
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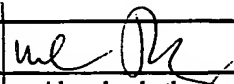
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